Application No.: 10/536,706

## AMENDMENTS TO THE CLAIMS

- 1. (Currently Amended) A method of growing a p-type nitride semiconductor material by molecular beam epitaxy, the method comprising supplying bis(cyclopentadienyl)magnesium (Cp<sub>2</sub>Mg) during the growth process, and carrying out the growth process at a temperature from 920°C to 960°C so that carbon contamination caused by Cp<sub>2</sub>Mg is reduced in the semiconductor material.
- 2. (Previously Presented) A method as claimed in claim 1, wherein the nitride semiconductor material is p-type (Ga,Al)N.
- 3. (Previously Presented) A method as claimed in claim 1, comprising supplying ammonia gas during the growth process.
- 4. (Previously Presented) A method as claimed in claim 1, comprising supplying ammonia gas, gallium and Cp<sub>2</sub>Mg to a growth chamber, thereby to grow a layer of p-type GaN.
- 5. (Previously Presented) A method as claimed in claim 1, comprising supplying ammonia gas, aluminum, gallium and Cp<sub>2</sub>Mg to a growth chamber, thereby to grow a layer of p-type AlGaN.
- 6. (Previously Presented) A method as claimed in 1, comprising changing the supply rate of Cp<sub>2</sub>Mg during the growth of the nitride semiconductor material.
- 7-10. (Cancelled)
- 11. (Previously Presented) A method as claimed in claim 1, wherein the growth process is carried out at a temperature of at least 950°C.

Application No.: 10/536,706

12. (Cancelled)

- 13. (Previously Presented) A method as claimed in claim 1, comprising supplying  $Cp_2Mg$  at a beam equivalent pressure of at least 1 x  $10^{-9}$  mbar.
- 14. (Previously Presented) A method as claimed in claim 1, comprising supplying  $Cp_2Mg$  at a beam equivalent pressure of at least 3 x  $10^{-9}$  mbar.
- 15. (Previously Presented) A method as claimed in claim 1, comprising supplying  $Cp_2Mg$  at a beam equivalent pressure of 1 x  $10^{-7}$  mbar or below.
- 16. (Previously Presented) A method as claimed in claim 1, comprising supplying  $Cp_2Mg$  at a beam equivalent pressure of 1.5 x  $10^{-8}$  mbar or below.
- 17. (Previously Presented) A method as claimed in claim 4, comprising supplying elemental gallium at a beam equivalent pressure of at least  $1 \times 10^{-8}$  mbar.
- 18. (Previously Presented) A method as claimed in claim 4, comprising supplying elemental gallium at a beam equivalent pressure of  $1 \times 10^{-5}$  mbar or below.
- 19. (Previously Presented) A method as claimed in claim 5, comprising supplying elemental gallium and elemental aluminum at an overall beam equivalent pressure of at least  $1 \times 10^{-8}$  mbar.
- 20. (Previously Presented) A method as claimed in claim 5, comprising supplying elemental gallium and elemental aluminum at an overall beam equivalent pressure of 1 x 10<sup>-5</sup>mbar or below.

21-23. (Canceled)